

PHOTOCOUPLER

PS2805-1,PS2805-4

HIGH ISOLATION VOLTAGE AC INPUT RESPONSE TYPE SOP PHOTOCOUPLER

-NEPOC[™] Series-

DESCRIPTION

The PS2805-1 and PS2805-4 are optically coupled isolators containing GaAs light emitting diodes and an NPN silicon phototransistor in a plastic SOP for high density applications.

This package has shield effect to cut off ambient light.

FEATURES

- High isolation voltage (BV = 2 500 Vr.m.s.)
- Small and thin package (4,16-pin SOP, Pin pitch 1.27 mm)
- High collector to emitter voltage (VcEO = 80 V)
- · AC input response
- High-speed switching ($t_r = 3 \mu s$ TYP., $t_f = 5 \mu s$ TYP.)
- Ordering number of tape product: PS2805-1-F3, F4, PS2805-4-F3, F4
- ★ Safety standards: PS2805-1, -4
 - UL approved: File No. E72422 (S)
 - BSI approved: No. 8188, 8189
 - VDE0884 approved (Option): PS2805-4 only

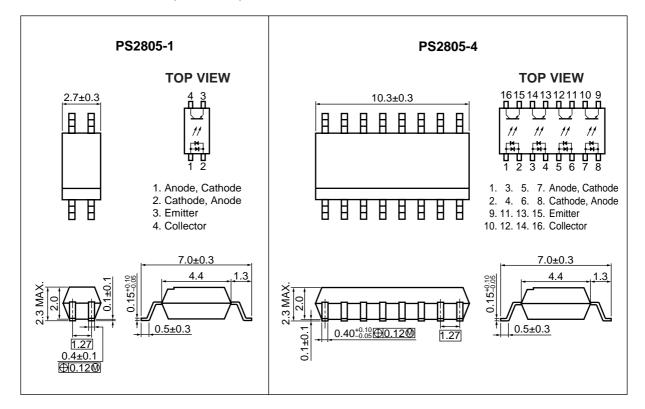
APPLICATIONS

- · Programmable logic controllers
- · Measuring instruments
- Hybrid IC

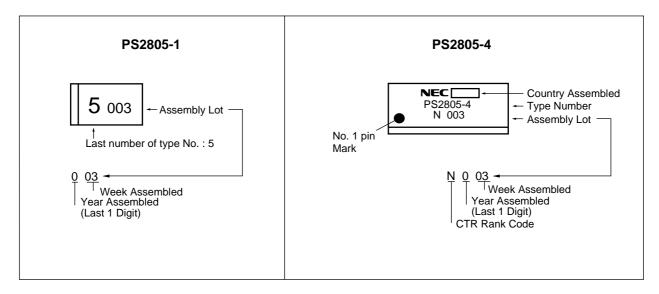
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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

PACKAGE DIMENSIONS (UNIT: mm)



★ MARKING



★ ORDERING INFORMATION

Part Number	Package	Packing Style	Application Part Number*1	
PS2805-1	4-pin SOP	50 pcs (Tape 50 pcs cut)	PS2805-1	
PS2805-1-F3		Embossed Tape 3 500 pcs/reel		
PS2805-1-F4				
PS2805-4	16-pin SOP	Magazine Case 45 pcs	PS2805-4	
PS2805-4-F3		Embossed Tape 2 500 pcs/reel		
PS2805-4-F4				

^{*1} For the application of the Safety Standard, following part number should be used.

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C, unless otherwise specified)

Parameter		Symbol	Ratings		Unit
			PS2805-1	PS2805-4	
Diode	Forward Current (DC)	lF	±50		mA
	Power Dissipation Derating	∆P _D /°C	0.6	0.8	mW/°C
	Power Dissipation	P□	60	80	mW/ch
	Peak Forward Current [™]	IFP	±1		Α
Transistor	Collector to Emitter Voltage	VCEO	80		٧
	Emitter to Collector Voltage	VECO	(3	V
	Collector Current	Ic	5	0	mA/ch
	Power Dissipation Derating	∆Pc/°C	1.	2	mW/°C
	Power Dissipation	Pc	12	20	mW/ch
Isolation Voltage ²		BV	2 500		Vr.m.s.
Operating Ambient Temperature		TA	-55 to +100		°C
Storage Temperature		T _{stg}	-55 to +150		°C

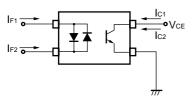
^{*1} PW = 100 μ s, Duty Cycle = 1 %

^{*2} AC voltage for 1 minute at $T_A = 25$ °C, RH = 60 % between input and output

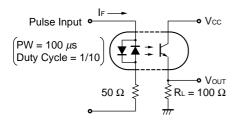
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Diode	Forward Voltage	VF	$I_F = \pm 5 \text{ mA}$		1.1	1.4	V
	Terminal Capacitance	Ct	V = 0 V, f = 1.0 MHz		30		pF
Transistor	Collector to Emitter Dark Current	Iceo	Vce = 80 V, I _F = 0 mA			100	nA
Coupled	Current Transfer Ratio (Ic/IF)	CTR	$I_F = \pm 5 \text{ mA}, \text{ VCE} = 5 \text{ V}$	80		600	%
	CTR Ratio [™]	CTR1/ CTR2	IF = 5 mA, VCE = 5 V	0.3	1.0	3.0	
	Collector Saturation Voltage	VCE(sat)	$I_F = \pm 10 \text{ mA}, I_C = 2 \text{ mA}$			0.3	V
	Isolation Resistance	R _{I-O}	Vi-o = 1.0 kVpc	10 ¹¹			Ω
	Isolation Capacitance	Cı-o	V = 0 V, f = 1.0 MHz		0.4		pF
	Rise Time *2	tr	$Vcc = 5 \text{ V}, \text{ Ic} = 2 \text{ mA}, \text{ RL} = 100 \Omega$		3		μs
	Fall Time*2	t f			5		

*1 CTR1 = Ic1/IF1, CTR2 = Ic2/IF2

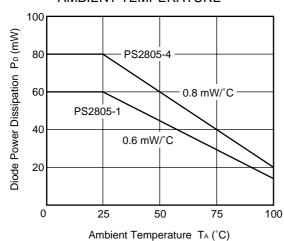


*2 Test circuit for switching time

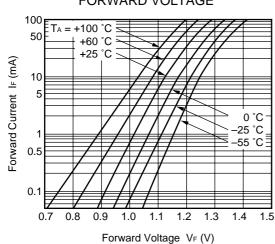


TYPICAL CHARACTERISTICS (TA = 25 °C, unless otherwise specified)

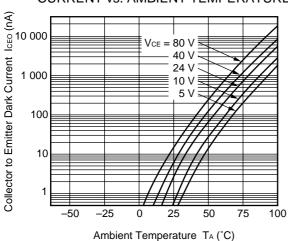
DIODE POWER DISSIPATION vs. AMBIENT TEMPERATURE



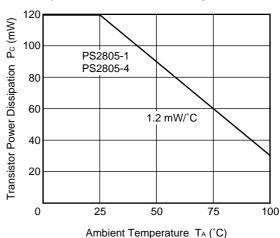
FORWARD CURRENT vs. FORWARD VOLTAGE



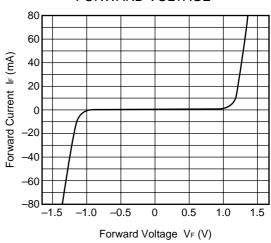
COLLECTOR TO EMITTER DARK CURRENT vs. AMBIENT TEMPERATURE



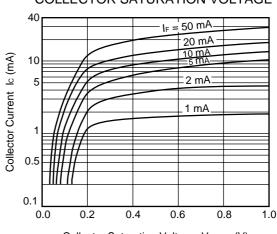
TRANSISTOR POWER DISSIPATION vs. AMBIENT TEMPERATURE



FORWARD CURRENT vs. FORWARD VOLTAGE

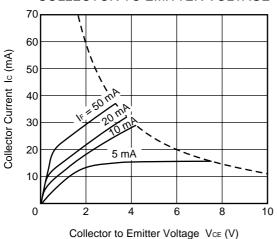


COLLECTOR CURRENT vs. COLLECTOR SATURATION VOLTAGE

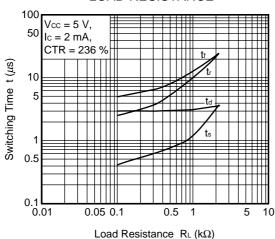


Collector Saturation Voltage VCE(sat) (V)

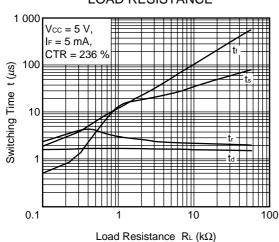
COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE



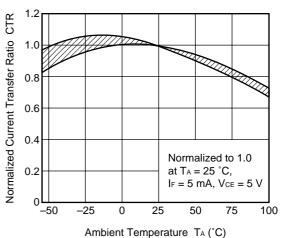
SWITCHING TIME vs. LOAD RESISTANCE



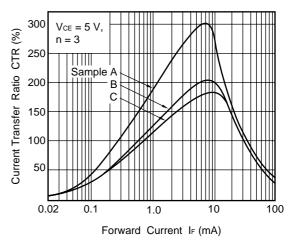
SWITCHING TIME vs. LOAD RESISTANCE



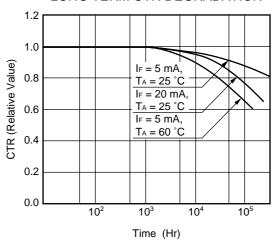
NORMALIZED CURRENT TRANSFER RATIO vs. AMBIENT TEMPERATURE



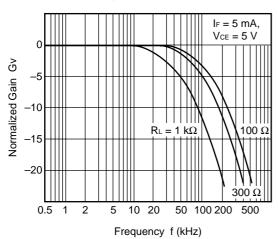
CURRENT TRANSFER RATIO vs. FORWARD CURRENT



LONG TERM CTR DEGRADATION



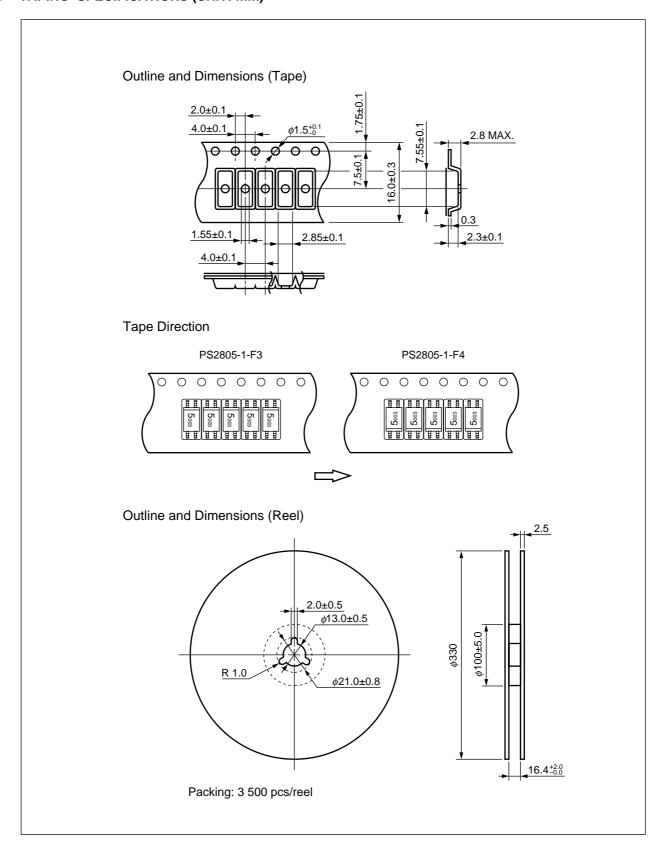
FREQUENCY RESPONSE

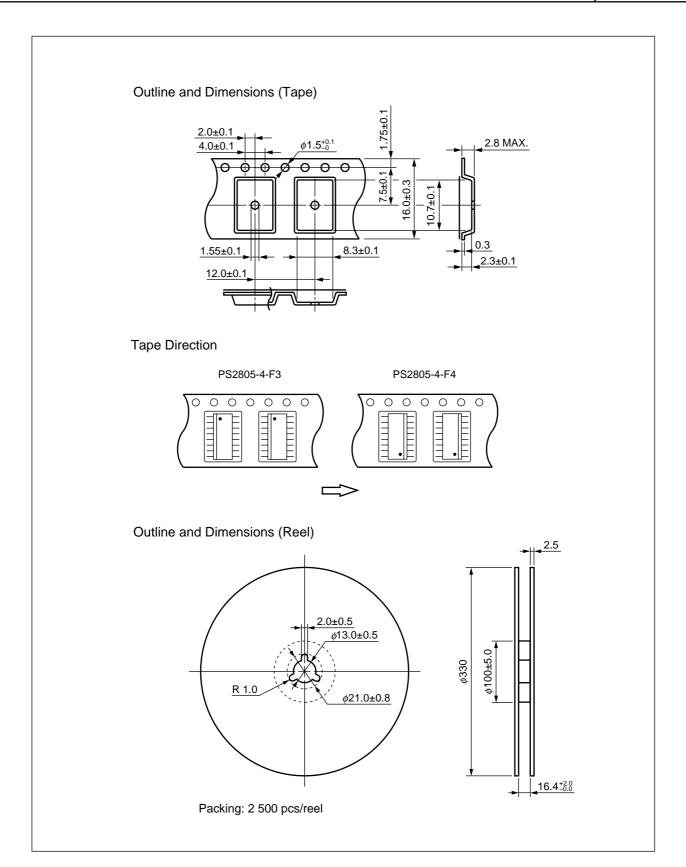


Remark The graphs indicate nominal characteristics.

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★ TAPING SPECIFICATIONS (UNIT: mm)





NOTES ON HANDLING

1. Recommended soldering conditions

(1) Infrared reflow soldering

• Peak reflow temperature 235 °C or below (package surface temperature)

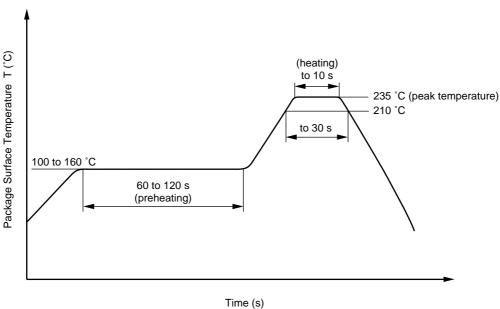
• Time of temperature higher than 210 °C 30 seconds or less

· Number of reflows Three

• Flux Rosin flux containing small amount of chlorine (The flux with a

maximum chlorine content of 0.2 Wt % is recommended.)

Recommended Temperature Profile of Infrared Reflow



(2) Dip soldering

 Temperature 260 °C or below (molten solder temperature)

• Time 10 seconds or less

 Number of times One (Allowed to be dipped in solder including plastic mold portion.)

Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of • Flux

0.2 Wt % is recommended.)

(3) Cautions

Fluxes

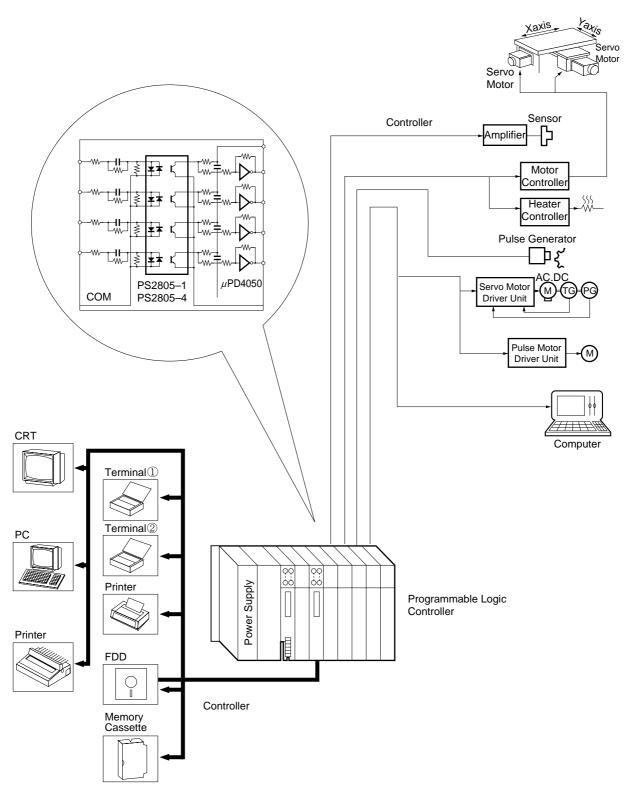
Avoid removing the residual flux with freon-based and chlorine-based cleaning solvent.

2. Cautions regarding noise

Be aware that when voltage is applied suddenly between the photocoupler's input and output or between corrector-emitters at startup, the output side may enter the on state, even if the voltage is within the absolute maximum ratings.

PROGRAMMABLE LOGIC CONTROLLERS EXAMPLE

Purpose: In-out interface



CAUTION

Within this device there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.

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M8E 00.4